


<b>Search Notes</b>  	<b>Application/Control No.</b>  10675348	<b>Applicant(s)/Patent Under Reexamination</b>  WATANABE ET AL.
	<b>Examiner</b>  Lee, John W	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
348	187, 164	06/18/2007	John W. Lee
348	207.7	06/20/2007	John W. Lee

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	06/07/2007	John W. Lee
EAST Search	06/07/2007	John W. Lee

INTERFERENCE SEARCH			
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